

This device is designed for low level, high gain, low noise general purpose amplifier applications at collector currents to 50 mA. Sourced from Process 62.

Absolute Maximum Ratings* TA = 25°C unless otherwise noted

Symbol	Parameter	Value	Units	
V _{CEO}	Collector-Emitter Voltage	50	V	
V _{CBO}	Collector-Base Voltage	50	V	
V _{EBO}	Emitter-Base Voltage	5.0	V	
I _C	Collector Current - Continuous	100	mA	
T _J , T _{stg}	Operating and Storage Junction Temperature Range	-55 to +150	°C	

*These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

NOTES: 1) These ratings are based on a maximum junction temperature of 150 degrees C.

2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

Thermal Characteristics TA= 25°C unless otherwise noted

Symbol	Characteristic	Мах		Units	
		2N5086 2N5086	*MMBT5086 *MMBT5087		
P _D	Total Device Dissipation Derate above 25°C	625 5.0	350 2.8	mW mW/∘C	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	83.3		°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	200	357	°C/W	

Device mounted on FR-4 PCB 1.6" X 1.6" X 0.06."

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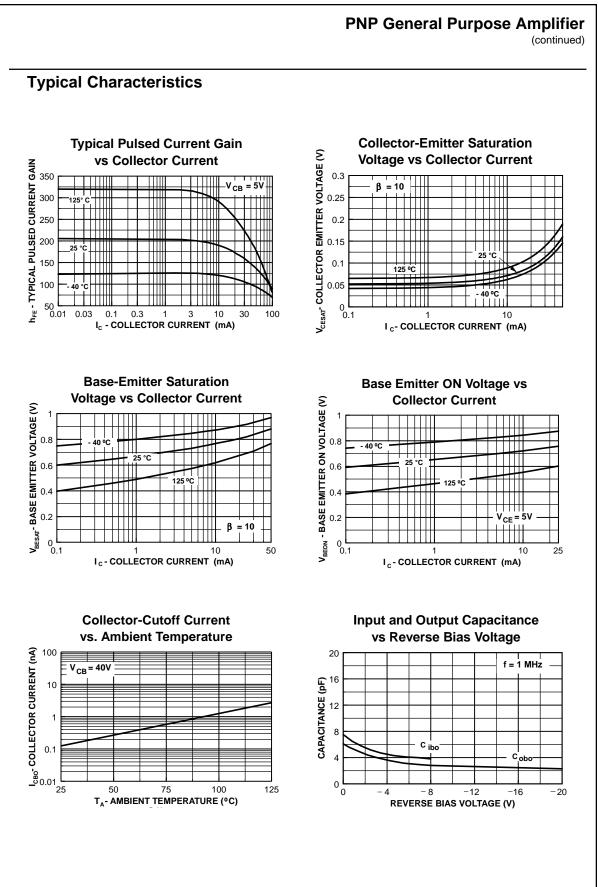
Electr	ical Characteristics TA=	25°C unless otherwise noted		1	n
Symbol	Parameter	Test Conditions	Min	Max	Units
OFF CHA	RACTERISTICS				
V _{(BR)CEO}	Collector-Emitter Breakdown Voltage*	$I_{\rm C} = 1.0 \text{ mA}, I_{\rm B} = 0$	50		V
V _{(BR)CBO}	Collector-Base Breakdown Voltage	$I_{\rm C} = 100 \ \mu {\rm A}, \ I_{\rm E} = 0$	50		V
I _{CBO}	Collector Cutoff Current	$V_{CB} = 10 \text{ V}, I_E = 0$		10	nA
I _{EBO}	Emitter Cutoff Current	$V_{CB} = 35 \text{ V}, \text{ I}_{E} = 0$ $V_{EB} = 3.0 \text{ V}, \text{ I}_{C} = 0$		50 50	nA nA
h _{FE}	DC Current Gain	$I_{C} = 100 \ \mu A, V_{CE} = 5.0 \ V$ 2N5086 2N5087	150 250	500 800	
		2N5087 I _C = 1.0 mA, V _{CE} = 5.0 V 2N5086	250 150	800	
		2N5087	250		
		$I_{C} = 10 \text{ mA}, V_{CE} = 5.0 \text{ V}$ 2N5086 2N5087	150 250		
V _{CE(sat)}	Collector-Emitter Saturation Voltage	$I_{\rm C} = 10 \text{ mA}, I_{\rm B} = 1.0 \text{ mA}$	250	0.3	V
V _{BE(On)}	Base-Emitter On Voltage	$I_{\rm C} = 1.0 \text{ mA}, V_{\rm CE} = 5.0 \text{ V}$		0.85	V
BE(01)					
SMALL S	IGNAL CHARACTERISTICS				
f _T	Current Gain - Bandwidth Product	$I_{C} = 500 \ \mu A, V_{CE} = 5.0 \ V, f = 20 \ MHz$	40		MHz
		$V_{CB} = 5.0 \text{ V}, I_E = 0, f = 100 \text{ kHz}$ 4.0		pF	
C _{cb}	Collector-Base Capacitance	$V_{CB} = 5.0 \text{ V}, I_E = 0, I = 100 \text{ KHZ}$		4.0	рг

		-			
C _{cb}	Collector-Base Capacitance	$V_{CB} = 5.0 \text{ V}, I_E = 0, f = 100 \text{ kHz}$		4.0	pF
h _{fe}	Small-Signal Current Gain	$I_{C} = 1.0 \text{ mA}, V_{CE} = 5.0,$ 2N5086	150	600	
		f = 1.0 kHz 2N5087	250	900	
NF	Noise Figure	$I_{C} = 100 \ \mu A, V_{CE} = 5.0 \ V, \ 2N5086$		3.0	dB
		$R_{s} = 3.0 \text{ k}\Omega, f = 1.0 \text{ kHz}$ 2N5087		2.0	dB
		$I_{\rm C} = 20 \ \mu A, \ V_{\rm CE} = 5.0 \ V,$ 2N5086		3.0	dB
		$R_s = 10 k\Omega$, 2N5087		2.0	dB
		f = 10 Hz to 15.7 kHz			

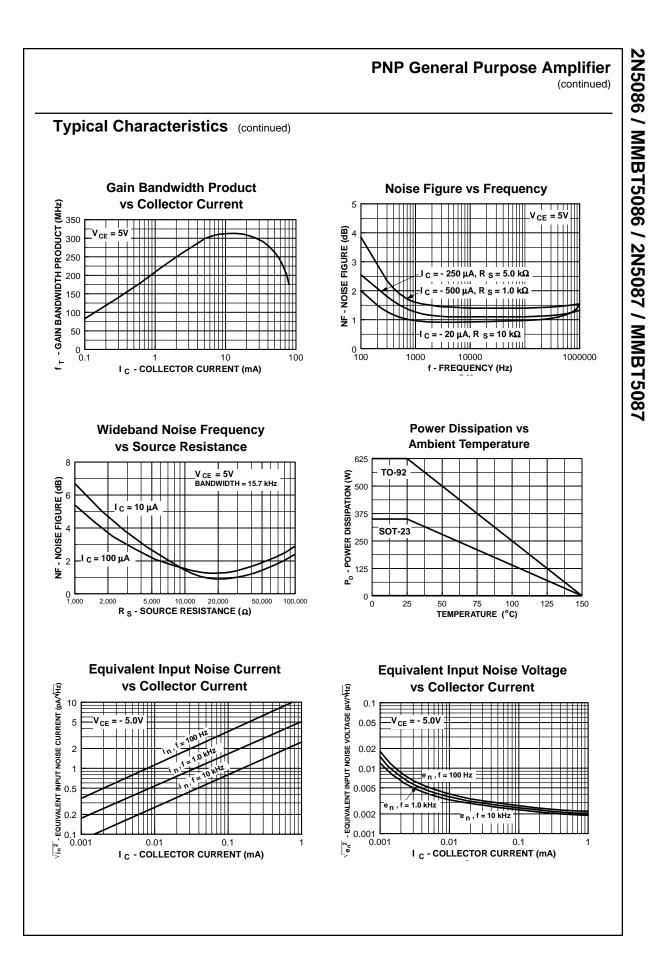
*Pulse Test: Pulse Width £ 300 ms, Duty Cycle £ 2.0%

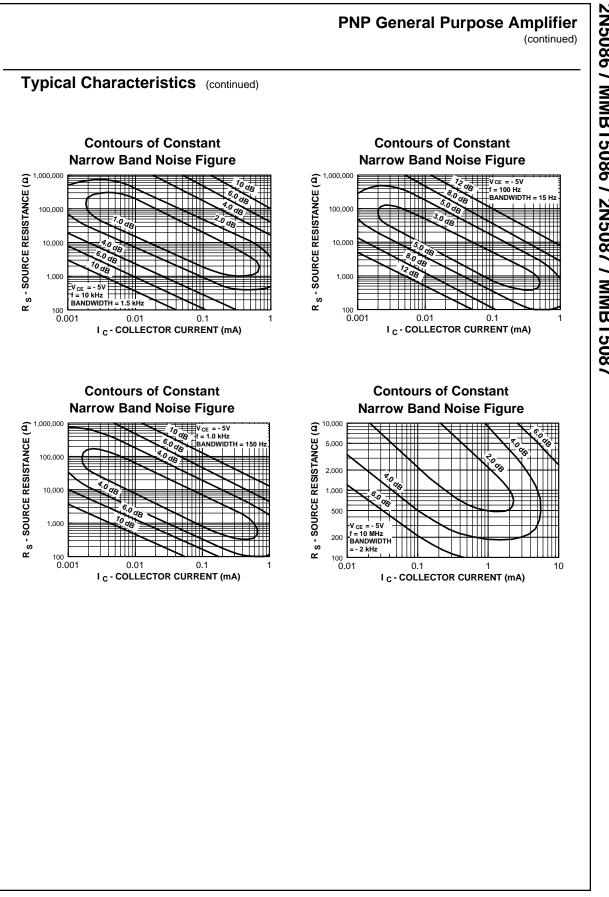
Spice Model

PNP (ls=6.734f Xti=3 Eg=1.11 Vaf=45.7 Bf=254.1 Ne=1.741 lse=6.734f lkf=.1962 Xtb=1.5 Br=2.683 Nc=2 lsc=0 lkr=0 Rc=1.67 Cjc=6.2p Mjc=.301 Vjc=.75 Fc=.5 Cje=7.5p Mje=.2861 Vje=.75 Tr=10.1n Tf=467.8p ltf=.17 Vtf=5 Xtf=8 Rb=10)



2N5086 / MMBT5086 / 2N5087 / MMBT5087





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